Product data sheet

1. General description

Planar passivated Silicon Controlled Rectifier in a TO247 plastic package intended for use in applications requiring very high inrush current capability and high thermal cycling performance.

2. Features and benefits

- High junction operating temperature capability (T_{j(max)} = 150 °C)
- Very high current surge capability
- · Planar passivated for voltage ruggedness and reliability
- High thermal cycling performance
- High voltage capability

3. Applications

- Line rectifying 50/60 Hz
- · Softstart AC motor control
- Motor control
- Power converter
- AC power control
- Lighting and temperature control
- Uninterruptible Power Supply (UPS)
- Solid State Relay (SSR)
- · Traction battery charging
- Hybrid PV Inverter

4. Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Notes	Values	Unit
Absolute	maximum rating				
V_{DRM}	repetitive peak off-state voltage			1200	V
V_{RRM}	repetitive peak reverse voltage			1200	V
I _{T(RMS)}	RMS on-state current	half sine wave; T _{mb} ≤ 131 °C; Fig. 1; Fig. 2; Fig. 3		79	А
I _{TSM}	non-repetitive peak on- state current	half sine wave; $T_{j(init)}$ = 25 °C; t_p = 10 ms; Fig. 4; Fig. 5		600	А
		half sine wave; $T_{j(init)}$ = 25 °C; t_p = 8.3 ms		660	А
T _j	junction temperature			150	°C

Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
Static ch	Static characteristics						
I _{GT}	gate trigger current	$V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; T_j = 25 \text{ °C}; Fig. 7$		-	-	80	mA
I _H	holding current	V _D = 12 V; T _j = 25 °C; <u>Fig. 9</u>		-	-	160	mA
V_T	on-state voltage	I _T = 50 A; T _j = 25 °C; <u>Fig. 10</u>		-	-	1.40	V
Dynamic	Dynamic characteristics						
dV _D /dt	rate of rise of off-state voltage	V_{DM} = 804 V; T_j = 150 °C; (V_{DM} = 67% of V_{DRM}); exponential waveform; gate open circuit		2000	-	-	V/µs

5. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	K	cathode		A N. 1/
2	A	anode		A K G
3	G	gate		sym037
mb	A	mounting base; connected to anode	TO247	

6. Ordering information

Table 3. Ordering information

Type number	Package Name	Orderable part number	Packing method	Small packing quantity	Package version	Package issue date
TYN50W-1200T	TO247	TYN50W-1200TQ	Tube	30	TO247P	31-Mar-2023

7. Marking

Table 4. Marking codes

Type number	Marking codes
TYN50W-1200T	TYN50W 1200T

8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Notes	Values	Unit
V_{DRM}	repetitive peak off-state voltage			1200	V
V_{RRM}	repetitive peak reverse voltage			1200	V
I _{T(AV)}	average on-state current	half sine wave; T _{mb} ≤ 131 °C		50	Α
I _{T(RMS)}	RMS on-state current	half sine wave; T _{mb} ≤ 131 °C; Fig 1; Fig 2; Fig 3		79	А
I _{TSM}	non-repetitive peak on- state current	half sine wave; $T_{j(init)}$ = 25 °C; t_p = 10 ms; Fig 4; Fig 5		600	А
		half sine wave; $T_{j(init)} = 25 ^{\circ}C$; $t_p = 8.3 ms$		660	Α
I ² t	I ² t for fusing	t _p = 10 ms; sine-wave pulse		1800	A ² s
dl _⊤ /dt	rate of rise of on-state current	I _G = 160 mA		300	A/µs
I _{GM}	peak gate current			8	Α
V_{RGM}	peak reverse gate voltage			5	V
P_GM	peak gate power			20	W
$P_{G(AV)}$	average gate power	over any 20 ms period		1	W
T _{stg}	storage temperature			-40 to 150	°C
T _j	junction temperature			-40 to 150	°C
	I	I .			

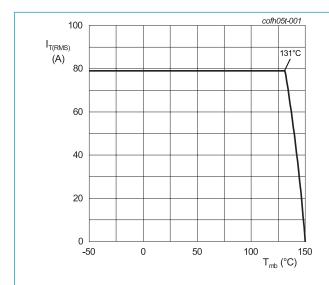
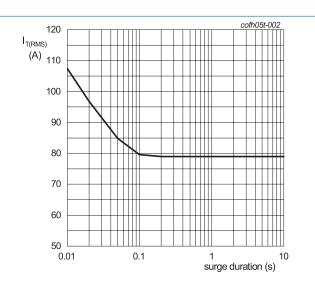


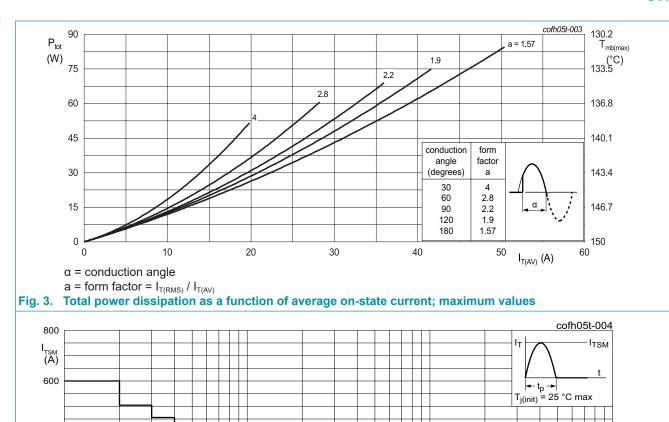
Fig. 1. RMS on-state current as a function of mounting base temperature; maximum values



 $f = 50 \text{ Hz}; T_{mb} = 131 \text{ }^{\circ}\text{C}$

Fig. 2. RMS on-state current as a function of surge duration; maximum values

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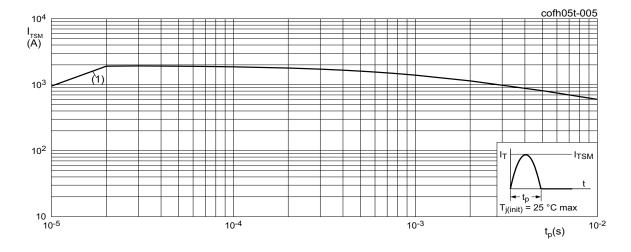


f = 50 Hz

Fig. 4. Non-repetitive peak on-state current as a function of the number of sinusoidal current cycles; maximum

10²

10



 $t_p \le 10 \text{ ms}$ (1) $dI_T/dt \text{ limit}$

Fig. 5. Non-repetitive peak on-state current as a function of pulse width; maximum values

400

200

0

10³

number of cycles (n)

9. Thermal & Mechanical characteristics

Table 6. Thermal & Mechanical characteristics

Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
R _{th(j-mb)}	thermal resistance from junction to mounting base	<u>Fig 6</u>		-	-	0.22	K/W
R _{th(j-a)}	thermal resistance from junction to ambient free air	in free air		-	50	-	K/W
	Mounting torque	M3 screw mounting		0.55	-	0.8	Nm

Note: It is recommended that a metal washer is inserted between screw head and mounting tab. Do not use self-tapping screws.

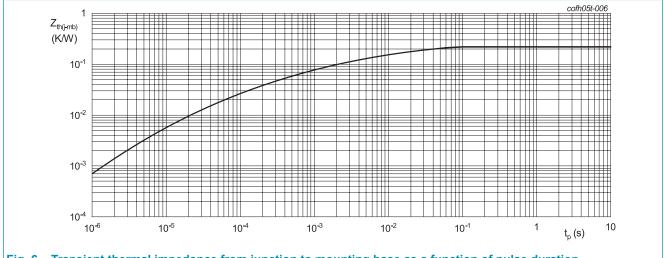


Fig. 6. Transient thermal impedance from junction to mounting base as a function of pulse duration

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10. Characteristics

Table 7. Characteristics

Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
Static cha	aracteristics						
I _{GT}	gate trigger current	$V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; T_j = 25 \text{ °C};$ Fig. 7; Fig. 8		-	-	80	mA
IL	latching current	$V_D = 12 \text{ V}; I_G = 0.1 \text{ A}; T_j = 25 \text{ °C};$ Fig. 9		-	-	180	mA
I _H	holding current	V _D = 12 V; T _j = 25 °C; <u>Fig. 10</u>		-	-	160	mA
V _T	on-state voltage	I _T = 50 A; T _j = 25 °C; <u>Fig. 11</u>		-	-	1.40	V
V_{GT}	gate trigger voltage	$V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; T_j = 25 ^{\circ}\text{C}; Fig. 12$		-	0.7	1	V
		V _D = 800 V; I _T = 0.1 A; T _j = 150 °C		0.25	0.45	-	V
I _D	off-state current	V _D = 1200 V; T _j = 25 °C		-	-	10	μΑ
		V _D = 1200 V; T _j = 125 °C		-	-	3	mA
I _R	reverse current	V _D = 1200 V; T _j = 25 °C		-	-	10	μA
		V _D = 1200 V; T _j = 125 °C		-	-	3	mA
Dynamic	characteristics						
dV _D /dt	rate of rise of off-state voltage	V_{DM} = 804 V; T_j = 150 °C; Gate open circuit; (V_{DM} = 67% of V_{DRM}); exponential waveform		2000	-	-	V/µs
t _{gt}	gate-controlled turn-on time	$I_{TM} = 50 \text{ A}; V_D = 800 \text{ V}; I_G = 0.1 \text{ A}; dI_G/dt = 5 \text{ A/}\mu\text{s}; T_j = 25 °C$		-	2	-	μs
t _q	commutated turn-off time	$V_{DM} = 804 \text{ V; } T_{j} = 125 \text{ °C; } I_{TM} = 50 \text{ A; } V_{R} = 25 \text{ V; } (dI_{T}/dt)_{M} = 30 \text{ A/µs; } dV_{D}/dt = 50 \text{ V/µs; } R_{GK(ext)} = 100 \text{ k}\Omega; (V_{DM} = 67\% \text{ of } V_{DRM})$		-	150	-	μs

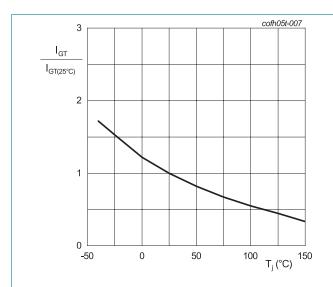


Fig. 7. Normalized gate trigger current as a function of junction temperature

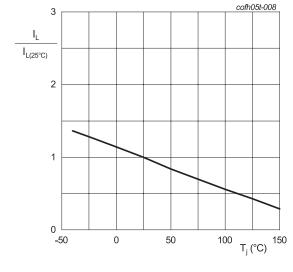


Fig. 8. Normalized latching current as a function of junction temperature

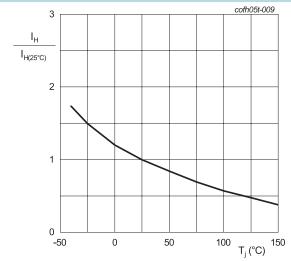
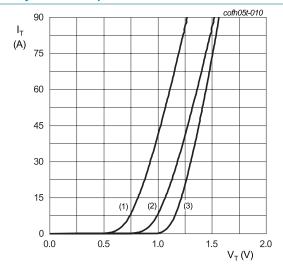


Fig. 9. Normalized holding current as a function of junction temperature



 V_o = 1.080 V; R_s = 0.0048 Ω (1) T_j = 150 °C; typical values (2) T_j = 150 °C; maximum values (3) T_i = 25 °C; maximum values

Fig. 11. On-state current as a function of on-state voltage

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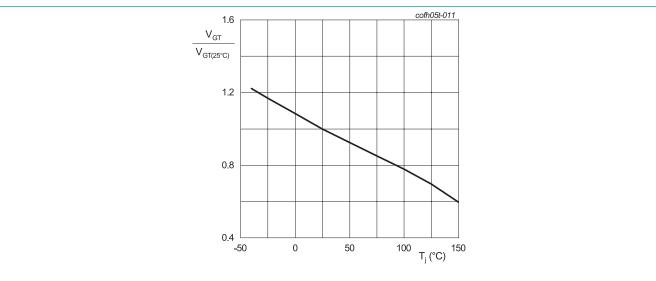
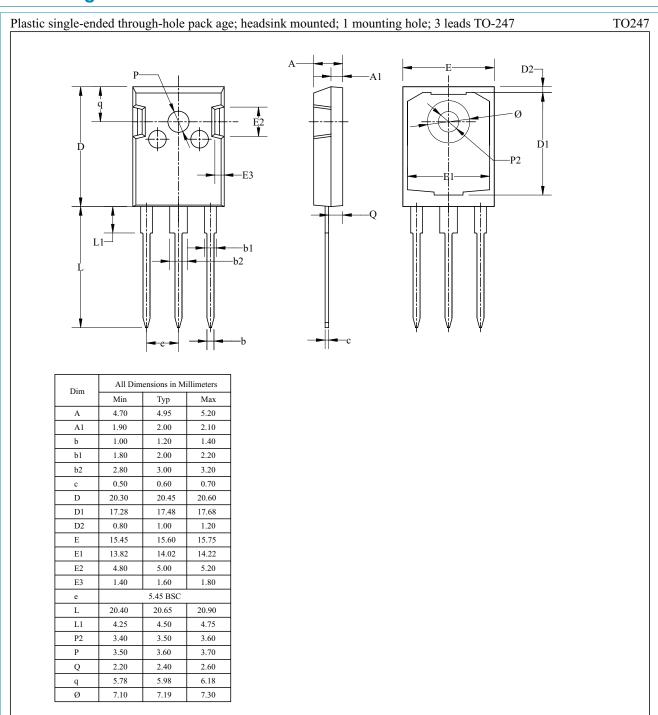


Fig. 11. Normalized gate trigger voltage as a function of junction temperature

11. Package outline



12. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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For more information, please visit: http://www.ween-semi.com
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